

<b>Search Notes</b> 	<b>Application/Control No.</b>  10/645,525	<b>Applicant(s)/Patent under Reexamination</b>  MASSASSO ET AL.
	<b>Examiner</b>  Jinhee J. Lee	<b>Art Unit</b>  2174

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner
715	text	11/25/2006	LEE